Search Notes						

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/645,402	ALONE ET AL.	
Examiner	Art Unit	
David Q. Nguyen	2681	

SEARCHED				
Class	Subclass	Date	Examiner	
455	414.[	02/01/06	W	
45	435.1		1	
550	222			
330	329			
709	222	03/01/06	m	
455	052.1	1		
	44.1		$I_{j}$	
455	41.2	85/01/06	pn	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East search	02/01/06	a	
East search Search note	02/01/06	m	